

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/811,170	SLEEMAN ET AL.	
Examiner	Art Unit	_
Jon M. Lockard	1647	

	SEARCHED				
Class	Subclass	Date	Examiner		
NONE		10/26/2005	JML		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
STIC Search of Commercial and Patent Databases of SEQ ID NOs:1 and 2. See Attached Search Report.	9/28/2005	JML		
East Search (USPAT, US-PGPUB, EPO, DERWENT): Inventor's Name Search. See Attached Search History.	10/27/2005	JML		
PALM: Inventor's Name Search.	10/26/2005	JML		
STN (MEDLINE, SCISEARCH, EMBASE, BIOSIS): See Attached Search History.	10/27/2005	JML		
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